# A Tutorial on Stochastic Models and Statistical Analysis for Frequency Stability Measurements

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#### Introduction

- time scales limited by clock noise
- can model clock noise as stochastic process  $\{X_t\}$ 
  - set of random variables (RVs) indexed by t
  - $-X_t$  represents clock noise at time t
  - will concentrate on sampled data, for which will take  $t \in \mathbb{Z} \equiv \{\dots, -1, 0, 1, \dots\}$ (but sometimes use  $t \in \mathbb{Z}^* \equiv \{0, 1, 2, \dots\}$ )
- Q: which stochastic processes are useful models?
- Q: how can we deduce model parameters & other characteristics from observed data?
- will cover the following in this tutorial:
  - stationary processes & closely related processes
  - fractionally differenced & related processes
  - two analysis of variance ('power') techniques
    - \* spectral analysis
    - \* wavelet analysis
  - parameter estimation via analysis techniques

#### Stationary Processes: I

- stochastic process  $\{X_t\}$  called stationary if
  - $-E{X_t} = \mu_X$  for all t; i.e., a constant that does not depend on t
  - $-\operatorname{cov}\{X_t, X_{t+\tau}\} = s_{X,\tau}, \text{ all possible } t \& t + \tau;$ i.e., depends on lag  $\tau$ , but not t
- $\{s_{X,\tau} : \tau \in \mathbb{Z}\}$  is autocovariance sequence (ACVS)
- $s_{X,0} = \operatorname{cov}\{X_t, X_t\} = \operatorname{var}\{X_t\};$ i.e., process variance is constant for all t
- spectral density function (SDF) given by

$$S_X(f) = \sum_{\tau = -\infty}^{\infty} s_{X,\tau} e^{-i2\pi f\tau}, \quad |f| \le 1/2$$

note:  $S_X(-f) = S_X(f)$  for real-valued processes

#### Stationary Processes: II

• if 
$$\{X_t\}$$
 has SDF  $S_X(\cdot)$ , then

$$\int_{-1/2}^{1/2} S_X(f) e^{i2\pi f\tau} \, df = s_{X,\tau}, \quad \tau \in \mathbb{Z}$$

• setting  $\tau = 0$  yields fundamental result:

$$\int_{-1/2}^{1/2} S_X(f) \, df = s_{X,0} = \operatorname{var} \{ X_t \};$$

i.e., SDF decomposes var  $\{X_t\}$  across frequencies f

• if  $\{a_u\}$  is a filter, then (with 'matching condition')

$$Y_t \equiv \sum_{u=-\infty}^{\infty} a_u X_{t-u}$$

is stationary with SDF given by

$$S_Y(f) = \mathcal{A}(f)S_X(f)$$
, where  $\mathcal{A}(f) \equiv \left|\sum_{u=-\infty}^{\infty} a_u e^{-i2\pi f u}\right|^2$ 

• if  $\{a_u\}$  narrow-band of bandwidth  $\Delta f$  about f, i.e.,

$$\mathcal{A}(f') = \begin{cases} \frac{1}{2\Delta f}, & f - \frac{\Delta f}{2} \le |f'| \le f + \frac{\Delta f}{2} \\ 0, & \text{otherwise,} \end{cases}$$

then have following interpretation for  $S_X(f)$ :

var 
$$\{Y_t\} = \int_{-1/2}^{1/2} S_Y(f') df' = \int_{-1/2}^{1/2} \mathcal{A}(f') S_X(f') df' \approx S_X(f)$$

### White Noise Process

- simplest stationary process is white noise
- $\{\epsilon_t\}$  is white noise process if
  - $-E\{\epsilon_t\} = \mu_{\epsilon} \text{ for all } t \text{ (usually take } \mu_{\epsilon} = 0)$  $\operatorname{var} \{\epsilon_t\} = \sigma_{\epsilon}^2 \text{ for all } t$  $\operatorname{cov} \{\epsilon_t, \epsilon_{t'}\} = 0 \text{ for all } t \neq t'$
- white noise thus stationary with ACVS

$$s_{\epsilon,\tau} = \operatorname{cov} \{\epsilon_t, \epsilon_{t+\tau}\} = \begin{cases} \sigma_{\epsilon}^2, & \tau = 0; \\ 0, & \text{otherwise,} \end{cases}$$

and SDF

$$S_{\epsilon}(f) = \sum_{\tau = -\infty}^{\infty} s_{X,\tau} e^{-i2\pi f\tau} = \sigma_{\epsilon}^{2}$$

### **Backward Differences of White Noise**

• consider first order backward difference of white noise:

$$X_t = \epsilon_t - \epsilon_{t-1} = \sum_{u=-\infty}^{\infty} a_u \epsilon_{t-u} \text{ with } a_u \equiv \begin{cases} 1, & u = 0; \\ -1, & u = 1; \\ 0, & \text{otherwise.} \end{cases}$$

- have  $S_X(f) = \mathcal{A}(f)S_{\epsilon}(f) = |2\sin(\pi f)|^2\sigma_{\epsilon}^2 \approx |2\pi f|^2\sigma_{\epsilon}^2$ at low frequencies (using  $\sin(x) \approx x$  for small x)
- let *B* be backward shift operator:  $B\epsilon_t = \epsilon_{t-1}$ ,  $B^2\epsilon_t = \epsilon_{t-2}, (1-B)\epsilon_t = \epsilon_t - \epsilon_{t-1}$ , etc.
- consider dth order backward difference of white noise:

$$X_{t} = (1-B)^{d} \epsilon_{t} = \sum_{k=0}^{d} {\binom{d}{k}} (-1)^{k} \epsilon_{t-k}$$
$$= \sum_{k=0}^{d} \frac{d!}{k!(d-k)!} (-1)^{k} \epsilon_{t-k}$$
$$= \sum_{k=0}^{\infty} \frac{\Gamma(1-\delta)}{\Gamma(k+1)\Gamma(1-\delta-k)} (-1)^{k} \epsilon_{t-k}$$
with  $\delta = -d$  i.e.  $\delta = -1$ .

with  $\delta \equiv -d$ , i.e.,  $\delta = -1, -2, \ldots$ 

• SDF given by

$$S_X(f) = \mathcal{A}(f)S_{\epsilon}(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^{2\delta}}$$

### **Fractional Differences of White Noise**

• for  $\delta$  not necessary an integer,

$$X_t = \sum_{k=0}^{\infty} \frac{\Gamma(1-\delta)}{\Gamma(k+1)\Gamma(1-\delta-k)} (-1)^k \epsilon_{t-k} \equiv \sum_{k=0}^{\infty} a_k(\delta) \epsilon_{t-k}$$

makes sense as long as  $\delta < 1/2$ 

- $\{X_t\}$  stationary fractionally differenced (FD) process
- SDF is as before:

$$S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^{2\delta}}$$

•  $\{X_t\}$  said to obey power law at low frequencies if

$$\lim_{f \to 0} \frac{S_X(f)}{C|f|^{\alpha}} = 1$$

for C > 0; i.e.,  $S_X(f) \approx C |f|^{\alpha}$  at low frequencies

- FD processes obey above with  $\alpha = -2\delta$
- note: FD process reduces to white noise when  $\delta = 0$

#### **ACVS & PACS for FD Processes**

• for  $\delta < 1/2$  &  $\delta \neq 0, -1, \dots$ , ACVS given by  $s_{X,\tau} = \sigma_{\epsilon}^2 \frac{\sin(\pi\delta)\Gamma(1-2\delta)\Gamma(\tau+\delta)}{\pi\Gamma(1+\tau-\delta)};$ when  $\delta = 0, -1, \dots$ , have  $s_{X,\tau} = 0$  for  $|\tau| > -\delta$  &  $s_{X,\tau} = \sigma_{\epsilon}^2 \frac{(-1)^{\tau}\Gamma(1-2\delta)}{\Gamma(1+\tau-\delta)\Gamma(1-\tau-\delta)}, \quad 0 \le |\tau| \le -\delta$ 

• for all  $\delta < 1/2$ , have

$$s_{X,0} = \operatorname{var} \{X_t\} = \sigma_{\epsilon}^2 \frac{\Gamma(1-2\delta)}{\Gamma^2(1-\delta)},$$

and rest of ACVS can be computed easily via

$$s_{X,\tau} = s_{X,\tau-1} \frac{\tau + \delta - 1}{\tau - \delta}, \quad \tau \in \mathbb{Z}^+ \equiv \{1, 2, \ldots\}$$

(for negative lags  $\tau$ , recall that  $s_{X,-\tau} = s_{X,\tau}$ ).

• for all  $\delta < 1/2$ , partial autocorrelation sequence (PACS) given by

$$\phi_{t,t} \equiv \frac{\delta}{t-\delta}, \quad t \in \mathbb{Z}^+$$

(useful for constructing best linear predictors)

• FD processes thus have simple and easily computed expressions for SDF, ACVS and PACS

#### Simulating Stationary FD Processes

- for  $-1 \leq \delta < 1/2$ , can obtain exact simulations via 'circulant embedding' (Davies–Harte algorithm)
- given  $s_{X,0}, \ldots, s_{X,N}$ , use discrete Fourier transform (DFT) to compute

$$S_k \equiv \sum_{\tau=0}^N s_{X,\tau} e^{-i2\pi f_k \tau} + \sum_{\tau=N+1}^{2N-1} s_{X,2N-\tau} e^{-i2\pi f_k \tau}, \quad k = 0, \dots, N$$

• given 2N independent Gaussian deviates  $\varepsilon_t$  with mean zero and variance  $\sigma_{\epsilon}^2$ , compute

$$\mathcal{Y}_{k} \equiv \begin{cases} \varepsilon_{0}\sqrt{2NS_{0}}, & k = 0; \\ (\varepsilon_{2k-1} + i\varepsilon_{2k})\sqrt{NS_{k}}, & 1 \leq k < N; \\ \varepsilon_{2N-1}\sqrt{2NS_{N}}, & k = N; \\ \mathcal{Y}_{2N-k}^{*}, & N < k \leq 2N-1; \end{cases}$$

(asterisk denotes complex conjugate)

• use inverse DFT to construct the real-valued sequence  $Y_t = \frac{1}{2N} \sum_{k=1}^{2N-1} \mathcal{V}_k e^{i2\pi f_k t}, \quad t = 0, \dots, 2N-1$ 

$$Y_t = \frac{1}{2N} \sum_{k=0} \mathcal{Y}_k e^{i2\pi i f_k t}, \quad t = 0, \dots, 2N - 1$$

- $Y_0, Y_1, \ldots, Y_{N-1}$  is exact simulation of FD process
- implication: can represent  $X_0, X_1, \dots, X_{N-1}$  as  $X_t = \sum_{k=0}^{2N-1} c_{t,k}(\delta) \varepsilon_k$  rather than  $X_t = \sum_{k=0}^{\infty} a_k(\delta) \epsilon_{t-k}$

### Nonstationary FD Processes: I

- suppose  $X_t^{(1)}$  is FD process with parameter  $\delta^{(s)}$  such that  $-1/2 \le \delta^{(s)} < 1/2$
- define  $X_t, t \in \mathbb{Z}^*$ , as cumulative sum of  $X_t^{(1)}, t \in \mathbb{Z}^*$ :

$$X_t \equiv \sum_{l=0}^t X_l^{(1)}$$

(for l < 0, let  $X_t \equiv 0$ )

• since, for  $t \in \mathbb{Z}^*$ ,

$$X_t^{(1)} = X_t - X_{t-1} \& S_{X^{(1)}}(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta^{(s)}}},$$

filtering theory suggests using relationship

$$S_{X^{(1)}}(f) = |2\sin(\pi f)|^2 S_X(f)$$

to define SDF for  $X_t$ , i.e.,

$$S_X(f) = \frac{S_{X^{(1)}}(f)}{|2\sin(\pi f)|^2} = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}}$$

with  $\delta \equiv \delta^{(s)} + 1$  (Yaglom, 1958)

#### Nonstationary FD Processes: II

- $X_t$  has stationary 1st order backward differences
- 1 sum defines FD processes for  $1/2 \le \delta < 3/2$
- 2 sums define FD processes for  $3/2 \le \delta < 5/2$ , etc
- $X_t$  has stationary 2nd order backward differences, etc
- if  $X_t^{(1)}$  is white noise  $(\delta^{(s)} = 0)$  so  $S_{X^{(1)}}(f) = \sigma_{\epsilon}^2$ , then  $X_t$  is random walk  $(\delta = 1)$  with

$$S_X(f) = \frac{\sigma_\epsilon^2}{|2\sin(\pi f)|^2} \approx \frac{\sigma_\epsilon^2}{|2\pi f|^2}$$

• if  $X_t^{(2)}$  is white noise and if

$$X_t^{(1)} \equiv \sum_{l=0}^t X_l^{(2)} \& X_t \equiv \sum_{l=0}^t X_l^{(1)}, \quad t \in \mathbb{Z}^*,$$

then  $X_t$  is random run ( $\delta = 2$ ), and

$$S_X(f) \approx \frac{\sigma_\epsilon^2}{|2\pi f|^4}$$

#### **Summary of FD Processes**

•  $X_t$  said to be FD process if its SDF is given by

$$S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^{2\delta}}$$
 at low frequencies

- well-defined for any real-valued  $\delta$
- FD process obeys power law at low frequencies with exponent  $\alpha = -2\delta$
- if  $\delta < 1/2$ , FD process stationary with

– ACVS given by

$$s_{X,0} = \sigma_{\epsilon}^2 \frac{\Gamma(1-2\delta)}{\Gamma^2(1-\delta)} \& s_{X,\tau} = s_{X,\tau-1} \frac{\tau+\delta-1}{\tau-\delta}, \quad \tau \in \mathbb{Z}^+$$

- PACS given by

$$\phi_{t,t} \equiv \frac{\delta}{t-\delta}, \quad t \in \mathbb{Z}^+$$

• if  $\delta \geq 1/2$ , FD process nonstationary but its *d*th order backward difference is stationary FD process with parameter  $\delta^{(s)}$ , where

$$d \equiv \lfloor \delta + 1/2 \rfloor$$
 and  $\delta^{(s)} \equiv \delta - d$ 

(here  $\lfloor x \rfloor$  is largest integer  $\leq x$ )

#### Alternatives to FD Processes: I

• fractional Brownian motion (FBM)

 $-B_H(t), 0 \le t < \infty$ , has SDF given by

$$S_{B_H(t)}(f) = \frac{\sigma_X^2 C_H}{|f|^{2H+1}}, \quad -\infty < f < \infty,$$

where  $\sigma_X^2 > 0$ ,  $C_H > 0 \& 0 < H < 1$ (*H* called Hurst parameter;  $C_H$  depends on *H*)

– power law with  $-3 < \alpha < -1$ 

#### • discrete fractional Brownian motion (DFBM)

$$-B_t, t \in \mathbb{Z}^+$$
, is DFBM if  $B_t = B_H(t)$ 

 $-B_t$  has SDF given by

$$S_{B_t}(f) = \sigma_X^2 C_H \sum_{j=-\infty}^{\infty} \frac{1}{|f+j|^{2H+1}}, \quad |f| \le 1/2$$

– power law at low frequencies with  $-3 < \alpha < -1$ 

- reduces to random walk if H = 1/2

#### Alternatives to FD Processes: II

$$-X_t, t \in \mathbb{Z}^+$$
, is FGN if  $X_t = B_{t+1} - B_t$ 

 $-X_t$  has SDF given by

$$S_X(f) = 4 \sigma_X^2 C_H \sin^2(\pi f) \sum_{j=-\infty}^{\infty} \frac{1}{|f+j|^{2H+1}}, \quad |f| \le 1/2$$

- power law at low frequencies with  $-1 < \alpha < 1$
- $-X_t$  is stationary, with ACVS given by

$$s_{X,\tau} = \frac{\sigma_X^2}{2} \left( |\tau + 1|^{2H} - 2|\tau|^{2H} + |\tau - 1|^{2H} \right), \quad \tau \in \mathbb{Z},$$
  
where  $\sigma_X^2 = \operatorname{var} \{X_t\}$ 

– reduces to white noise if H = 1/2

#### • discrete pure power law (PPL) process

- SDF given by  $S_X(f) = C_S |f|^{\alpha}$ ,  $|f| \le 1/2$
- if  $\alpha > -1$ , stationary, but ACVS takes some effort to compute
- if  $\alpha = 0$ , reduces to white noise
- $-\alpha \leq -1$ , nonstationary but backward differences of certain order are stationary

#### FD Processes vs. Alternatives

- FD processes cover full range of power laws
  - FBMs, DFBMs and FGNs cover limited range
  - PPL processes also cover full range
- differencing FD process yields another FD process; differencing alternatives yields new type of process
- FD process has simple SDF; if stationary, has simple ACVS & PACS
  - FBM has simple SDF
  - DFBM has complicated SDF
  - FGN has simple ACVS, complicated SDF & PACS
  - PPL has simple SDF, complicated ACVS & PACS
- FD, DFBM, FGN and PPL model sampled noise
  - might be problematic to change sampling rate
  - FBM models unsampled noise
- Fig. 1: comparison of SDFs for FGN, PPL & FD
- Fig. 2: comparison of realizations

#### Extensions to FD Processes: I

• composite FD processes

$$S_X(f) = \sum_{m=1}^{M} \frac{\sigma_m^2}{|2\sin(\pi f)|^{2\delta_m}};$$

i.e., linear combinations of independent FD processes

- autoregressive, fractionally integrated, moving average (ARFIMA) processes
  - idea is to replace  $\epsilon_t$  in

$$X_t = \sum_{k=0}^{\infty} a_k(\delta) \epsilon_{t-k}$$

with ARMA process, say,

$$U_t = \sum_{k=1}^p \phi_k U_{t-k} + \epsilon_t - \sum_{k=1}^q \theta_k \epsilon_{t-k}$$

- yields process with SDF

$$S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \cdot \frac{\left|1 - \sum_{k=1}^q \theta_k e^{-i2\pi fk}\right|^2}{\left|1 - \sum_{k=1}^p \phi_k e^{-i2\pi fk}\right|^2}$$

 ARMA part can model, e.g., high-frequency structure in noise

### Extensions to FD Processes: II

• can define time-varying FD (TVFD) process via

$$X_t = \sum_{k=0}^{\infty} a_k(\delta_t) \epsilon_{t-k}$$

as long as  $\delta_t < 1/2$  for all t

- can use representation

$$X_{t} = \sum_{k=0}^{2N-1} c_{t,k}(\delta_{t})\varepsilon_{k}, \quad t = 0, 1, \dots, N-1,$$

to extend definition to handle arbitrary  $\delta_t$ 

- Fig. 3: realizations from 4 TVFD processes
- can also make  $\sigma_{\epsilon}^2$  time-varying

#### **FD** Process Parameter Estimation

- Q: given realization (clock noise) of  $X_0, \ldots, X_{N-1}$ from FD process, how can we estimate  $\delta \& \sigma_{\epsilon}^2$ ?
- *many* different estimators have been proposed! (area of active research)
- will concentrate on estimators based on
  - spectral analysis (frequency-based)
  - wavelet analysis (scale-based)
- advantages of spectral and wavelet analysis
  - physically interpretable
  - both are analysis of variance techniques (useful for more than just estimating  $\delta \& \sigma_{\epsilon}^2$ )
  - can assess need for models more complex than simple FD process (e.g., composite FD process)
  - provide preliminary estimates for more complicated schemes (maximum likelihood estimation)

#### Estimation via Spectral Analysis

• recall that SDF for FD process given by

$$S_X(f) = \frac{\sigma_\epsilon^2}{|2\sin(\pi f)|^{2\delta}}$$

and thus

$$\log \left( S_X(f) \right) = \log \left( \sigma_{\epsilon}^2 \right) - 2\delta \log \left( \left| 2\sin(\pi f) \right| \right);$$

i.e., plot of  $\log (S_X(f))$  vs.  $\log (|2\sin(\pi f)|)$  linear with slope of  $-2\delta$ 

• for 
$$0 < f < 1/8$$
, have  $\sin(\pi f) \approx \pi f$ , so

$$\log(S_X(f)) \approx \log(\sigma_{\epsilon}^2) - 2\delta \log(2\pi f);$$

i.e., plot of log  $(S_X(f))$  vs. log  $(2\pi f)$  approximately linear at low frequencies with slope of  $-2\delta = \alpha$ 

- basic scheme
  - estimate  $S_X(f)$  via  $\hat{S}_X(f)$
  - fit linear model to  $\hat{S}_X(f)$  vs.  $\log(2\pi f)$  over low frequencies
  - use estimated slope  $\hat{\alpha}$  to estimate  $\delta$  via  $-\hat{\alpha}/2$
  - use estimated intercept to estimate  $\sigma_{\epsilon}^2$

#### The Periodogram: I

• basic estimator of S(f) is periodogram:

$$\hat{S}^{(p)}(f) \equiv \frac{1}{N} \left| \sum_{t=0}^{N-1} X_t e^{-i2\pi f t} \right|^2, \qquad |f| \le 1/2;$$

• represents decomposition of sample variance:

$$\int_{-1/2}^{1/2} \hat{S}^{(p)}(f) \, df = \frac{1}{N} \sum_{t=0}^{N-1} X_t^2$$

• for stationary processes & large N, theory says

$$\hat{S}^{(p)}(f) \stackrel{\mathrm{d}}{=} S(f) \frac{\chi_2^2}{2}, \quad 0 < f < 1/2,$$

approximately, implying that

 $- E\{\hat{S}^{(p)}(f)\} \approx E\{S(f)\chi_2^2/2\} = S(f)$ - var  $\{\hat{S}^{(p)}(f)\} \approx var \{S(f)\chi_2^2/2\} = S^2(f)$ 

(in above ' $\stackrel{d}{=}$ ' means 'equal in distribution,' and  $\chi_2^2$  is chi-square RV with 2 degrees of freedom)

• additionally,  $\operatorname{cov} \{ \hat{S}^{(p)}(f_j), \hat{S}^{(p)}(f_k) \} \approx 0$ for  $f_j \equiv j/N \& 0 < f_j < f_k < 1/2$ 

### The Periodogram: II

• taking log transform yields

$$\log\left(\hat{S}^{(p)}(f)\right) \stackrel{\mathrm{d}}{=} \log\left(S(f)\frac{\chi_2^2}{2}\right) = \log\left(S(f)\right) + \log\left(\frac{\chi_2^2}{2}\right)$$

• Bartlett & Kendall (1946):

$$E\left\{\log\left(\frac{\chi_{\eta}^{2}}{\eta}\right)\right\} = \psi(\eta) - \log\left(\eta\right) \& \operatorname{var}\left\{\log\left(\frac{\chi_{\eta}^{2}}{\eta}\right)\right\} = \psi'(\eta)$$

where  $\psi(\cdot)$  &  $\psi'(\cdot)$  are di– & trigamma functions

 $\bullet$  yields

$$\begin{split} E\{\log{(\hat{S}^{(p)}(f))}\} &= \log{(S(f))} + \psi(2) - \log{(2)} \\ &= \log{(S(f))} - \gamma \\ \mathrm{var}\{\log{(\hat{S}^{(p)}(f))}\} &= \psi'(2) = \pi^2/6 \\ (\gamma \doteq 0.57721 \text{ is Euler's constant}) \end{split}$$

#### The Periodogram: III

- define  $Y^{(p)}(f_j) \equiv \log(\hat{S}^{(p)}(f_j)) + \gamma$
- can model  $Y^{(p)}(f_j)$  as

$$Y^{(p)}(f_j) \approx \log (S(f_j)) + \epsilon(f_j)$$
  
$$\approx \log (\sigma_{\epsilon}^2) - 2\delta \log (2\pi f_j) + \epsilon(f_j)$$

over low frequencies indexed by 0 < j < J

- error  $\epsilon(f_j)$  in linear regression model such that
  - $E\{\epsilon(f_j)\} = 0 \& \operatorname{var} \{\epsilon(f_j)\} = \pi^2/6 \text{ (known!)}$
  - if  $\{X_t\}$  Gaussian &  $\hat{S}^{(p)}(f_j)$ 's uncorrelated, then  $\epsilon(f_j)$ 's pairwise uncorrelated
  - $-\epsilon(f_j) \stackrel{\mathrm{d}}{=} \log(\chi_2^2)$  markedly non-Gaussian
- least squares procedure yields
  - estimates  $\hat{\delta}$  and  $\hat{\sigma}_{\epsilon}^2$  for  $\delta$  and  $\sigma_{\epsilon}^2$
  - estimates of variability in  $\hat{\delta}$  and  $\hat{\sigma}_{\epsilon}^2$

#### Multitaper Spectral Estimation: I

- warnings about periodogram:
  - approximations might require N to be *very* large!
  - approximations of questionable validity for nonstationary FD processes
- Fig. 4: periodogram can suffer from 'leakage'
- tapering is technique for alleviating leakage:

$$\hat{S}^{(d)}(f) \equiv \left|\sum_{t=0}^{N-1} a_t X_t e^{-i2\pi f t}\right|^2$$

 $- \{a_t\}$  called data taper (typically bell-shaped curve)

$$- \hat{S}^{(d)}(\cdot)$$
 called direct spectral estimator

- critique: loses 'information' at end of series (sample size N effectively shortened)
- Thomson (1982): multitapering recovers 'lost info'
- use set of K orthonormal data tapers  $\{a_{n,t}\}$ :

$$\sum_{t=0}^{N-1} a_{n,t} a_{l,t} = \begin{cases} 1, & \text{if } n = l; \\ 0, & \text{if } n \neq l. \end{cases} \quad 0 \le n, l \le K-1$$

#### Multitaper Spectral Estimation: II

• use  $\{a_{n,t}\}$  to form kth direct spectral estimator:

$$\hat{S}_{k}^{(mt)}(f) \equiv \left|\sum_{t=0}^{N-1} a_{n,t} X_{t} e^{-i2\pi f t}\right|^{2}, \quad n = 0, \dots, K-1$$

• simplest form of multitaper SDF estimator:

$$\hat{S}^{(mt)}(f) \equiv \frac{1}{K} \sum_{n=0}^{K-1} \hat{S}_n^{(mt)}(f)$$

• sinusoidal tapers are one family of multitapers:

$$a_{n,t} = \left\{\frac{2}{(N+1)}\right\}^{1/2} \sin\left\{\frac{(n+1)\pi(t+1)}{N+1}\right\}, \quad t = 0, \dots, N-1$$

(Riedel & Sidorenko, 1995)

- Figs. 5 and 6: example of multitapering
- if  $S(\cdot)$  slowly varying around S(f) & if N large,

$$\hat{S}^{(mt)}(f) \stackrel{\mathrm{d}}{=} \frac{S(f)\chi_{2K}^2}{2K}$$

approximately for 0 < f < 1/2, impling

var 
$$\{\hat{S}^{(mt)}(f)\} \approx \frac{S^2(f)}{4K^2}$$
 var  $\{\chi^2_{2K}\} = \frac{S^2(f)}{K}$ 

#### Multitaper Spectral Estimation: III

- define  $Y^{(mt)}(f_j) \equiv \log\left(\hat{S}^{(mt)}(f_j)\right) \psi(K) + \log\left(K\right)$
- can model  $Y^{(mt)}(f_j)$  as

$$Y^{(mt)}(f_j) \approx \log (S(f_j)) + \eta(f_j)$$
  
$$\approx \log (\sigma_{\epsilon}^2) - 2\delta \log (2\pi f_j) + \eta(f_j)$$

over low frequencies indexed by 0 < j < J

- error  $\eta(f_j)$  in linear regression model such that
  - $-E\{\eta(f_j)\}=0$
  - $\operatorname{var} \{\eta(f_j)\} = \psi'(K), \text{ a known constant!}$
  - approximately Gaussian if  $K \ge 5$
  - correlated, but with simple structure:

$$\operatorname{cov}\{\eta(f_j), \eta(f_{j+\nu})\} \approx \begin{cases} \psi'(K) \left(1 - \frac{|\nu|}{K+1}\right), & \text{if } |\nu| \le K+1; \\ 0, & \text{otherwise.} \end{cases}$$

- generalized least squares procedure yields
  - estimates  $\hat{\delta}$  and  $\hat{\sigma}_{\epsilon}^2$  for  $\delta$  and  $\sigma_{\epsilon}^2$
  - estimates of variability in  $\hat{\delta}$  and  $\hat{\sigma}_{\epsilon}^2$
- multitaper approach superior to periodogram approach

### Discrete Wavelet Transform (DWT)

- let  $\mathbf{X} = [X_0, X_1, \dots, X_{N-1}]^T$  be observed time series (for convenience, assume N integer multiple of  $2^{J_0}$ )
- let  $\mathcal{W}$  be  $N \times N$  orthonormal DWT matrix
- $\mathbf{W} = \mathcal{W}\mathbf{X}$  is vector of DWT coefficients
- orthonormality says  $\mathbf{X} = \mathcal{W}^T \mathbf{W}$ , so  $\mathbf{X} \Leftrightarrow \mathbf{W}$
- can partition **W** as follows:

$$\mathbf{W} = egin{bmatrix} \mathbf{W}_1 \ dots \ \mathbf{W}_{J_0} \ \mathbf{V}_{J_0} \end{bmatrix}$$

- $\mathbf{W}_j$  contains  $N_j = N/2^j$  wavelet coefficients
  - related to changes of averages at scale  $\tau_j = 2^{j-1}$ ( $\tau_j$  is *j*th 'dyadic' scale)
  - related to times spaced  $2^j$  units apart
- $\mathbf{V}_{J_0}$  contains  $N_{J_0} = N/2^{J_0}$  scaling coefficients
  - related to averages at scale  $\lambda_{J_0} = 2^{J_0}$
  - related to times spaced  $2^{J_0}$  units apart

#### Example: Haar DWT

- Fig. 7:  $\mathcal{W}$  for Haar DWT with N = 16
  - first 8 rows yield  $\mathbf{W}_1 \propto changes$  on scale 1
  - next 4 rows yield  $\mathbf{W}_2 \propto changes$  on scale 2
  - next 2 rows yield  $\mathbf{W}_3 \propto changes$  on scale 4
  - next to last row yields  $\mathbf{W}_4 \propto change$  on scale 8
  - last row yields  $\mathbf{V}_4 \propto average$  on scale 16
- Fig. 8: Haar DWT coefficients for clock 571

#### **DWT** in Terms of Filters

- filter  $X_0, X_1, \ldots, X_{N-1}$  to obtain  $2^{j/2} \widetilde{W}_{j,t} \equiv \sum_{l=0}^{L_j-1} h_{j,l} X_{t-l \mod N}, \quad t = 0, 1, \ldots, N-1;$  $h_{j,l}$  is *j*th level wavelet filter (note: circular filtering)
- subsample to obtain wavelet coefficients:

 $W_{j,t} = 2^{j/2} \widetilde{W}_{j,2^{j}(t+1)-1}, \quad t = 0, 1, \dots, N_{j} - 1,$ where  $W_{j,t}$  is the element of  $\mathbf{W}_{j}$ 

- Figs. 9 & 10: four sets of wavelet filters
- *j*th wavelet filter is band-pass with pass-band  $\left[\frac{1}{2^{j+1}}, \frac{1}{2^{j}}\right]$  (i.e., scale related to *interval* of frequencies)
- similarly, scaling filters yield  $\mathbf{V}_{J_0}$
- Figs. 11 & 12: four sets of scaling filters
- $J_0$ th scaling filter is low-pass with pass-band  $[0, \frac{1}{2^{J_0+1}}]$
- as width L of 1st level filters increases,
  - band-pass & low-pass approximations improve
  - # of embedded differencing operations increases (related to # of 'vanishing moments')

### **DWT-Based Analysis of Variance**

• consider 'energy' in time series:

$$\|\mathbf{X}\|^2 = \mathbf{X}^T \mathbf{X} = \sum_{t=0}^{N-1} X_t^2$$

• energy preserved in DWT coefficients:

$$\|\mathbf{W}\|^2 = \|\mathcal{W}\mathbf{X}\|^2 = \mathbf{X}^T\mathcal{W}^T\mathcal{W}\mathbf{X} = \mathbf{X}^T\mathbf{X} = \|\mathbf{X}\|^2$$

• since  $\mathbf{W}_1, \ldots, \mathbf{W}_{J_0}, \mathbf{V}_{J_0}$  partitions  $\mathbf{W}$ , have

$$\|\mathbf{W}\|^2 = \sum_{j=1}^{J_0} \|\mathbf{W}_j\|^2 + \|\mathbf{V}_{J_0}\|^2,$$

leading to analysis of sample variance:

$$\hat{\sigma}^2 \equiv \frac{1}{N} \sum_{t=0}^{N-1} X_t^2 = \frac{1}{N} \left( \sum_{j=1}^{J_0} \|\mathbf{W}_j\|^2 + \|\mathbf{V}_{J_0}\|^2 \right)$$

• scale-based decomposition (cf. frequency-based)

#### Variation: Maximal Overlap DWT

• can eliminate downsampling and use

$$\widetilde{W}_{j,t} \equiv \frac{1}{2^{j/2}} \sum_{l=0}^{L_j - 1} h_{j,l} X_{t-l \bmod N}, \quad t = 0, 1, \dots, N - 1$$

to define MODWT coefficients  $\widetilde{\mathbf{W}}_j$  (& also  $\widetilde{\mathbf{V}}_j$ )

- unlike DWT, MODWT is not orthonormal (in fact MODWT is highly redundant)
- like DWT, can do analysis of variance because

$$\|\mathbf{X}\|^{2} = \sum_{j=1}^{J_{0}} \|\widetilde{\mathbf{W}}_{j}\|^{2} + \|\widetilde{\mathbf{V}}_{J_{0}}\|^{2}$$

- unlike DWT, MODWT works for all samples sizes N (i.e., power of 2 assumption is not required)
- Fig. 13: Haar MODWT coefficients for clock 571 (cf. Fig. 8 with DWT coefficients)
- can use to track time-varying FD process

#### **Definition of Wavelet Variance**

- let  $X_t, t \in \mathbb{Z}$ , be a stochastic process
- run  $X_t$  through *j*th level wavelet filter:

$$\overline{W}_{j,t} \equiv \sum_{l=0}^{L_j - 1} \tilde{h}_{j,l} X_{t-l}, \quad t \in \mathbb{Z}$$

• definition of time dependent wavelet variance (also called wavelet spectrum):

$$\nu_{X,t}^2(\tau_j) \equiv \operatorname{var} \{ \overline{W}_{j,t} \},\$$

assuming var  $\{\overline{W}_{j,t}\}$  exists and is finite

- $\nu_{X,t}^2(\tau_j)$  depends on  $\tau_j$  and t
- will consider time independent wavelet variance:

$$\nu_X^2(\tau_j) \equiv \operatorname{var}\left\{\overline{W}_{j,t}\right\}$$

(can be easily adapted to time varying situation)

- rationale for wavelet variance
  - decomposes variance on scale by scale basis
  - useful substitute/complement for SDF

#### Variance Decomposition

• suppose  $X_t$  has SDF  $S_X(f)$ :

$$\int_{-1/2}^{1/2} S_X(f) \, df = \operatorname{var} \{ X_t \};$$

i.e., decomposes var  $\{X_t\}$  across frequencies f

- involves uncountably infinite number of f's
- $-S_X(f)\Delta f \approx \text{contribution to var} \{X_t\} \text{ due to } f\text{'s}$ in interval of length  $\Delta f$  centered at f
- note: var  $\{X_t\}$  taken to be  $\infty$  for nonstationary processes with stationary backward differences
- wavelet variance analog to fundamental result:

$$\sum_{j=1}^{\infty} \nu_X^2(\tau_j) = \operatorname{var} \{X_t\}$$

i.e., decomposes var  $\{X_t\}$  across scales  $\tau_j$ 

- recall DWT/MODWT and sample variance
- involves countably infinite number of  $\tau_j$ 's
- $-\nu_X^2(\tau_j)$  contribution to var  $\{X_t\}$  due to scale  $\tau_j$
- $-\nu_X(\tau_j)$  has same units as  $X_t$  (easier to interpret)

#### Spectrum Substitute/Complement

• because  $\tilde{h}_{j,l} \approx$  bandpass over  $[1/2^{j+1}, 1/2^j]$ ,

$$\nu_X^2(\tau_j) \approx 2 \int_{1/2^{j+1}}^{1/2^j} S_X(f) \, df$$
 (\*)

- if  $S_X(f)$  'featureless', info in  $\nu_X^2(\tau_j) \Leftrightarrow \inf S_X(f)$
- $\nu_X^2(\tau_j)$  more succinct: only 1 value per octave band
- recall SDF for FD process:

$$S_X(f) = \frac{\sigma_{\epsilon}^2}{|2\sin(\pi f)|^{2\delta}} \approx \frac{\sigma_{\epsilon}^2}{|2\pi f|^{2\delta}}$$

- (\*) implies  $\nu_X^2(\tau_j) \propto \tau_j^{2\delta-1}$  approximately
- can deduce  $\delta$  from slope of  $\log(\nu_X^2(\tau_j))$  vs.  $\log(\tau_j)$
- can estimate  $\delta \& \sigma_{\epsilon}^2$  by applying regression analysis to log of estimates of  $\nu_X^2(\tau_j)$

#### Estimation of Wavelet Variance: I

• can base estimator on MODWT of  $X_0, X_1, \ldots, X_{N-1}$ :

$$\widetilde{W}_{j,t} \equiv \sum_{l=0}^{L_j-1} \widetilde{h}_{j,l} X_{t-l \mod N}, \quad t = 0, 1, \dots, N-1$$

(DWT-based estimator possible, but less efficient)

• recall that

$$\overline{W}_{j,t} \equiv \sum_{l=0}^{L_j-1} \tilde{h}_{j,l} X_{t-l}, \quad t = 0, \pm 1, \pm 2, \dots$$

so  $\widetilde{W}_{j,t} = \overline{W}_{j,t}$  if mod not needed:  $L_j - 1 \le t < N$ 

• if  $N - L_j \ge 0$ , unbiased estimator of  $\nu_X^2(\tau_j)$  is

$$\hat{\nu}_X^2(\tau_j) \equiv \frac{1}{N - L_j + 1} \sum_{t=L_j - 1}^{N-1} \widetilde{W}_{j,t}^2 = \frac{1}{M_j} \sum_{t=L_j - 1}^{N-1} \overline{W}_{j,t}^2,$$

where  $M_j \equiv N - L_j + 1$ 

• can also construct biased estimator of  $\nu_X^2(\tau_j)$ :

$$\tilde{\nu}_X^2(\tau_j) \equiv \frac{1}{N} \sum_{t=0}^{N-1} \widetilde{W}_{j,t}^2 = \frac{1}{N} \Big( \sum_{t=0}^{L_j-2} \widetilde{W}_{j,t}^2 + \sum_{t=L_j-1}^{N-1} \overline{W}_{j,t}^2 \Big)$$

1st sum in parentheses influenced by circularity

## Estimation of Wavelet Variance: II

- biased estimator unbiased if  $\{X_t\}$  white noise
- biased estimator offers exact analysis of  $\hat{\sigma}^2$ ; unbiased estimator need not
- biased estimator can have better mean square error (Greenhall *et al.*, 1999; need to 'reflect'  $X_t$ )

### Statistical Properties of $\hat{\nu}_X^2(\tau_j)$

- suppose  $\{\overline{W}_{j,t}\}$  Gaussian, mean 0 & SDF  $S_j(f)$
- suppose square integrability condition holds:

$$A_j \equiv \int_{-1/2}^{1/2} S_j^2(f) \, df < \infty \& S_j(f) > 0$$

(holds for FD process if L large enough)

- can show  $\hat{\nu}_X^2(\tau_j)$  asymptotically normal with mean  $\nu_X^2(\tau_j)$  & large sample variance  $2A_j/M_j$
- can estimate  $A_j$  and use with  $\hat{\nu}_X^2(\tau_j)$ to construct confidence interval for  $\nu_X^2(\tau_j)$
- example
  - Fig. 14: clock errors  $X_t \equiv X_t^{(0)}$  along with differences  $X_t^{(i)} \equiv X_t^{(i-1)} X_{t-1}^{(i-1)}$  for i = 1, 2
  - Fig. 15:  $\hat{\nu}_X^2(\tau_j)$  for clock errors

– Fig. 16: 
$$\hat{\nu}_{\overline{Y}}^2(\tau_j)$$
 for  $\overline{Y}_t \propto X_t^{(1)}$ 

- Haar  $\hat{\nu}_{\overline{Y}}^2(\tau_j)$  related to Allan variance  $\sigma_{\overline{Y}}^2(2,\tau_j)$ :

$$\nu_{\overline{Y}}^2(\tau_j) = \frac{1}{2}\sigma_{\overline{Y}}^2(2,\tau_j)$$

#### Summary

- fractionally differenced processes are
  - able to cover all power laws
  - easy to work with (SDF, ACVS & PACS simply expressed)
  - extensible to composite, ARFIMA & time-varying processes
- spectral and wavelet analysis can provide
  - estimates of parameters of FD processes
  - decomposition of sample variance across
    - \* frequencies (in case of spectral analysis)
    - \* scales (in case of wavelet analysis)
  - complementary analyses
- wavelet analysis has some advantages for clock noise
  - estimates  $\delta \& \sigma_{\epsilon}^2$  somewhat better
  - useful with time-varying noise process
  - can deal with polynomial trends (not covered here)
  - results expressed in same units as  $X_t^2$
- a big 'thank you' to conference organizers!